Instruction Manual

Storagescope

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Innovators in Instrumentation

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Introduction

- ♦ Thank you very much for your purchase of LeCroy electronic measuring instruments.
- Please read this manual and understanding its contents before using this instrument. After reading this manual, please keep it for future reference.
- ♦ This instrument meets CE requirements per the Council Directive 89/336/EEC for Electromagnetic Compatibility and Low Voltage Directive 73/23/ECC for Product Safety.
- ◇ This instrument conforms to product safety requirements per UL3111 (as Pollution Degree 2 and Installation Category II) under file E183826.

Cautions for safe use

For safe operation of this instrument and for prevention of injury to operator and damage to property are described as " \bigwedge warnings" and " \bigwedge cautions" in this manual. The symbols are marked on the panel for attentions.

Explanation of "A warnings" and "A cautions" columns in this manual

<u>∕</u> . Warning	Incorrect operation may result in death or serious injury.
<u>∧</u> Caution	Incorrect operation may result in injury or damage to equipment.

Explanation of the symbols on the panel

Symbol	Meaning
	This symbol used in reference with the statements in the manual to protect the operator against injury and this instrument against damage.
777	Frame or chassis Terminal
	Risk of electric shock
	Earth (Ground) Terminal
	Protective Conductor Terminal

Cautions

- ◇ Parts of the contents of this manual may be modified without notice to accommodate improvements in performance and function.
- ♦ Reproduction of the contents of this manual without previous consent is prohibited.
- The TFT color LCD contains cold cathode fluorescent lamps. Please follow local ordinances or regulations for its disposal.

History

♦ May 1998 : Issue of the 1st edition

KML033511

\land Warnings

Do not use under explosive gas.

Otherwise it could result in explosion.

If there is any smoke, anomaly, or strange noise from this instrument, immediately power switch to STBY and disconnect the power cord.

Otherwise it could result in electrical shock or fire. After contact to our service offices. Repair by the user is dangerous and should be strictly prohibited.

Do not fall water into this instrument or wet to this instrument.

It result in electrical shock or fire. If water or other foreign liquid has felled into this instrument, turn the power switch to STBY and remove the power cord and then contact to our service offices.

Do not place on an unstable place as a shaky stand or slanted.

It could result in electrical shock, injury, or fire. If this instrument has dropped turn the power switch to STBY and remove the power cord and then contact to our service offices.

Do not fall any foreign matter from the air hole, etc.

It could result in fire, electrical shock, or power failure. If any foreign matter has been felled the power switch to STBY and remove the power cord and then contact to our service offices.

Use a 3-prong power cord.

If not, it could result in electrical shock or power failure.

- When supplying power from a 2-wire receptacle using a 3-core/2-core conversion adapter, connect the grounding terminal of the 3-core/2-core conversion adapter to ground.
- When connecting the power from a 3-wire receptacle by the attached 3-core power cord, the grounding wire of the power cord is connected to ground.

Warnings (cont'd)

Use this instrument with the rated AC power supply.

If not, it could result in electrical shock, fire, or power failure. The usable power voltage range (100 to 240 VAC) is marked on the rear panel.

Connect the probe ground and input connectors to the ground of the measuring object.

If not, it cause electrical shock or other accidents (damages to the measuring object, the instrument itself or other units) may occur. Refer to the "Example of improper way" shown below.

[Example of improper way]



When measuring the floating potential, measurement by the differential method (CH1 and CH2 input) is recommended. Refer to the example shown below. [Example of recommended measurement method]



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\Lambda Warnings (cont'd)



It could result in electrical shock, fire, or power failure. Repair of a modified instrument may be refused.

\land Cautions





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- Section

Unpacking

The figure below shows the unpacking procedure.



Terminology

•	
A sweep	: Main sweep system
ADD	: Display of the sum of CH1 waveform and CH2 waveform (abbreviation from ADDITION)
AC (input coupling)	: An input coupling system where a filter is applied to the input circuit so that the DC (direct current) component is eliminated from the signal
AC (trigger coupling)	: A trigger coupling system where a filter is applied to the trigger circuit so that the DC (direct current) component is eliminated from the signal
ALT (vertical)	: Alternately switched sweep of multiple channel waveforms on the same screen (abbreviation of ALTERNATE)
ALT (horizontal)	: Alternately display of A sweep and B sweep on the same screen (abbreviation of ALTERNATE)
ATTACH	: Selection of the object channel for cursor measurement or offset
AXIS (scale)	: Cross hair scale
BACK LIGHT	: Brightness of LCD (Liquid Crystal Display)
Bsweep	: The delayed sweep system
BEAM FIND	: Display the compressed waveform for the identification (abbreviation from BEAM FINDER)
B ENDS A	: To increase the brightness by shortening A sweep with delayed sweep (refer to "2.12 Delayed Sweep")
BOTH	: Both of the odd- and even-numbered fields of the TV vertical synchronizing signals
BURST	: One of event triggers, where a signal is triggered when the time interval of the trigger signal exceeds the specified period (refer to "2.9.6 Event Trigger")
BWL	: Limitation of the vertical bandwidth (abbreviation from BANDWIDTH LIMITER)
CAL	: A signal for calibration, which is used for calibration of deflection factor and the check of the operation of this instrument (abbreviation from CALIBRATION)
CCD	: Charge coupled device
CCIR	: One of TV observation scale
CH	: Channel (abbreviation from CHANNEL)
CHOP	: Alternately switches channel at 555kHz for displaying multiple waveforms on the same screen
CLAMP	: Display position of the TV signal is controlled as back porch level meet to ground level the reference level (ground level)
COUPLE	: Trigger coupling system (abbreviation from COUPLING)
COUNT	: One of event triggers, where a signal is triggered when the specified numbers of B trigger signals are counted after the A trigger signal occurred (refer to "2.9.6 Event Trigger")
CRT	: Cathode ray tube
DC (input coupling)	: The input coupling system that passes both DC and AC component of the signal

· . .

DC (trigger coupling)	: The trigger coupling system that pass both DC and AC component of the signal
DIV	: Division
EIA	: One of TV observation scale
ERASE	: Erases the STORAGE or PERSISTENCE waveform
EVEN	: Even-numbered fields of TV vertical synchronizing signals
EVENT	: Event trigger (this unit has the COUNT and BURST types)
FET	: Field effect transistor
FET probe	: An active probe with an FET at the tip
FRAME	: Frame scale
GND	: Grounding
Hcursor	: The cursor used for measuring time by moving in the horizontal direction
HDTV	: TV system of high-definition type (abbreviation from HIGH DEFINITION TELEVISION)
HFREJ	: Low-pass filter for eliminating high-frequency component (abbreviation from HIGH FREQUENCY REJECTION)
HOLDOFF	: Holdoff time (facilitate the observation of complex pulse signals by adjusting the holdoff time)
HORIZ	: Horizontal
INDEP	: Move the cursor independently (abbreviation from INDEPENDENCE)
INTEN	: Intensity, brightness of the trace (abbreviation from INTENSITY)
INV	: Inverting the vertical display on the screen (abbreviation from INVERT)
LF REJ	: High-pass filter for eliminating low-frequency component (abbreviation from LOW FREQUENCY REJECTION)
LINE (trigger signal so	urce) : One of trigger signal sources. A power line is used as a trigger signal source.
LINE (TV)	: Line No. of TV trigger mode
MAG	: Magnifying waveform in the horizontal direction (abbreviation from MAGNIFICATION)
MAX	: Maximum value
NTSC	: A color television system (abbreviation from NATIONAL TELEVISION SYSTEM COMMITTEE)
ODD	: Odd-numbered fields of TV vertical synchronizing signals
PAL	: A color television system (abbreviation from PHASE ALTERNATION BY LINE)
PERSISTENCE	: Persistence time of the storage waveforms
READOUT	: Brightness of character display (abbreviation from READOUT INTEN)
RH	: Relative humidity
RECALL	: Recalling the setting conditions from internal memory

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		-
RST	: Reset	
SAVE	: Saving the panel key setting conditions into internal memory	į
SCALE	: Graticule (abbreviation from SCALE)	i (
SECAM	: A color television system (abbreviation from SEQUENTIEAL COULEUR A MEMOIRE in French)	
SEP	: Controlling B sweep position from A sweep (abbreviation from SEPARATION)	
SGL	: Sweeps only once (abbreviation from SINGLE)	
SLOPE	: Trigger slope	
SOURCE	: Trigger signal source	
STBY	: Stand-by	
STORAGE	: Store the waveforms	
ТСК	: Moving 2 cursors with keeping the span (abbreviation from TRACKING)	
TRACE ROTATION	: Adjusting the alignment of a trace to horizontal graticule	
TRIG	: Trigger	
Tr (rise time)	: A pulse response characteristic - the transition time from 10 to 90% of the basic amplitude	
TV-H	: TV horizontal synchronizing signals	
TV-V	: TV vertical synchronizing signals	
V cursor	: The cursor used for measuring voltage by moving in the vertical direction	1000
VSWR	: Voltage standing wave ratio	
X-Y	: A system where different signals are input and displayed on the X and Y axes so as to observe the frequency ratio and/or phase difference between two signals	

- XII -

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Panel Controls

Symbols on the panel

: Warning symbol

This symbol is marked for the user's attention to refer in the instruction manual. This symbol is marked near the CH1 to CH4 INPUT terminals.

- 7/7 : This is ground for measurement.
 -) : Knob indication

One knob has two functions. While depressing the knob enables the other function (BEAM FIND (A INTEN), COARSE (FUNCTION)).



[

- : Pushing the knob enables the other function (STORAGE, ERASE, VARIABLE ON/OFF).
- <u>.</u> : Key indication

Pressing A, B keys simultaneously enable alternate sweep.

- Light indication
- : The indicator lights when B (sweep and trigger) or CHOP is selected.
- CAT II : Complies with IEC 1010 (installation (over voltage) category II)

Symbols in the instruction manual

Expression of keys and knobs

- : Indicates a key.
 -] : Indicates a knob. There are two types of knobs as follows :
 - · To be operated by turning.
 - To be operated by turning and pressing.

Pressing two switches simultaneously, they are expressed with a symbol of "+" inserted between them.
[Example]: A + B



Figure 1 Front Panel 1 (Overall view)

Front Panel

2

1 The Power Switch and Screen



Figure 2 Front Panel II

① **POWER** key

Turn the AC power ON or STBY. Refer to the column shown below.

- 2 [A INTEN (BEAM FIND)] knob
 - A INTEN knob : Adjusts the trace intensity of A sweep (refer to page 20 "Adjustment of the Screen").
 - BEAM FIND switch : Displays a compressed waveform on the screen while pressing the knob (refer to page 20 "Adjustment of the Screen").

③ [B INTEN] knob

Adjusts the trace intensity of B sweep (refer to page 20 "Adjustment of the Screen").

④ [READOUT(STORAGE)] knob

• READOUT knob : Adjusts the intensity of characters (refer to page 11 "Setting f:DISP-MENU") at full counter clock wise is READOUT (OFF) condition.

• STORAGE switch : Stores the all waveform on the screen (refer to page 46 "Storage Operation").

[FOCUS] knob

Adjusts the focus (refer to page 20 "Adjustment of the Screen").

6 TRACE ROTATION

Adjusts the alignment of the trace to horizontal graticule by using the driver (refer to page 20 "Adjustment of the Screen").

(PERSISTENCE (ERASE)] knob

- PERSISTENCE knob : Adjusts the persistent time of displaying waveform. Turning the knob full clockwise set to infinite persistence.
- ERASE switch : Erases the storage or persistent waveform (refer to page 46 "Storage Operation").



2 Vertical Axis



(CH1 to CH4)

Connector of input signals.

[Note] Do not apply over rating voltage to the input terminal.

- ② [VOLTS/DIV (VARIABLE)] (CH1, CH2) knob
 - VOLT/DIV switch : Selects the deflection factor in 1-2-5 steps (refer to page 22 "Deflection Factor"). VARIABLE switch : Finely adjusts the deflection factor continuously (refer to page 22 "Deflection Factor").
- ③ 100mV/500mV (CH3, CH4) key Selects the deflection factor (refer to page 22 "Deflection Factor").
- ④ [▲POSITION▼] (CH1 to CH4) knob

Controls the position in the vertical direction (refer to page 21 "Vertical and Horizontal Position").

5 DC/AC (CH1 to CH4) key

Selects the input coupling (refer to page 23 "Input Coupling").

- (CH1, CH2) key Connects the input coupling to the GND (refer to page 23 "Input Coupling").
- ⑦ 50 Ω/1 MΩ (CH1, CH2) key

Selects the input resistance. The indicator lights when 50Ω is selected (refer to page 24 "Input Resistance").

- ⑧ CH1, CH2, CH3, CH4 key Selects the display channel on the screen (refer to page 25 "Display Channels").
- ADD CH1 + CH2 key

Displays the sum of CH1 and CH2 (refer to page 26 "Sum and Difference").

10 INV key

Inverts the CH2 display (refer to page 26 "Sum and Difference").

4

3 Horizontal Axis, etc.



Supplies power to FET probes.

⑧ CAL terminal

Outputs calibration voltage signals. Used for operation check of this unit and the adjustment of the probe waveform (refer to page 16 "Displaying CAL Signal with AUTO SET").

(grounding) connector

This is the ground for measurement.

4 Trigger Section and Display Mode Section

① [TRIG LEVEL] knob

Selects the trigger point of the trigger signal (refer to page 30 "Trigger Level").

② READY indicator

Lights while waiting for signals in single sweep (SGL).

③ TRIG'Dindicator

Lights when a triggered.

(4 **AB** key

Selects A (sweep and trigger) or B (sweep and trigger) (refer to page 41 "Delayed Sweep"). The indicator lights when B is selected.

Figure 5 Front Panel V (Trigger Section and Display Mode Section)

5 **SLOPE** key

Selects the trigger slope (+, --) (refer to page 30 "Trigger Slope").

6 HOLDOFF key

Selects the holdoff time (refer to page 43 "Holdoff").

⑦ SOURCE key

Selects the trigger signal source (CH1, CH2, CH3, or LINE) (refer to page 29 "Trigger Source").

⑧ COUPL key

Selects the trigger coupling mode (AC, DC, HF REJ, or LF REJ) (refer to page 29 "Trigger Coupling").

③ TV key

Selects TV triggering with BOTH, ODD, EVEN, or TV-H (refer to page 31 "TV Signal").

10 EVENT/TV CLAMP key

Selects event (refer to page 30 "Event Trigger") or TV clamp (refer to page 32 "TV Clamp").

- HORIZ DISPLAY (display mode) -

1 A or B key

Displays A sweep or B sweep (refer to page 35 "Horizontal Display"). Depressing **A** and **B** simultaneously selects ALT sweep.

12 X-Y key

Selects X-Y mode (refer to page 35 "Horizontal Display").

(3) **DELAY/TRACE SEP** key

Selects DELAY (refer to page 41 "Delayed Sweep") or TRACE SEP (refer to page 36 "Trace Separation").

5 Functions, Cursors, Sweep Modes, etc.

① [FUNCTION] pulse switch

The delay time, cursor position, menu etc. can be set by turning or pressing this knob. Turning this knob effect fine adjustment. Coarse adjustments can be made in the direction the knob has been turned so far by pressing or holding down the button.

2 AUTOSET key

Measuring conditions are set automatically. (refer to page 17 "CAL wave display with AUTO SET").



Figure 6 Front Panel VI (Functions, Cursors, Sweep Modes, etc.)

- CURSORS -

③ ΔV key

Measures the voltage using a cursor (refer to page 49 "Counter and Cursor Measurement").

(4) Δt key

Measures the time using a cursor (refer to page 49 "Counter and Cursor Measurement").

5 TCK/INDEP key

Selects the cursor (C1, C2, or tracking) to be moved (refer to page 49 "Counter and Cursor Measurement").

6 SAVE/RECALL key

Selects Save or Recall (refer to page 56 "Save/Recall Setups").

- ⑦ **ATTACH** key
 - · Selects the object channel of the cursor measurement (refer to page 49 "Counter and Cursor Measurement").
 - · Selects the channel (CH1/CH2) or terminal (P1/P2) for the offset (refer to page 27 "CH1/CH2 Offset").
- 8 OFFSET key

Sets the offset of CH1/CH2 or FET probe (refer to page 28 "PROBE P1/P2 Offset").

- SWEEP MODE -

9 AUTO, NORM, SGL/RST key

Selects repetitive sweep (AUTO, NORM) or single sweep (SGL) (refer to page 40 "Sweep Mode").

Rear Panel



Figure 7 Rear Panel

① AC LINE INPUT terminal

Connects the power cord to this inlet.

2 FUSE

 ϕ 5×20 mm, 250 V, T5A fuse. (Installs the appropriate fuse)

③ CH2 OUTPUT terminal

Outputs the signal input to CH2 INPUT.

Amplitude of output signal = Amplitude on the screen Xoutput voltage

④ Z AXIS IN terminal

Inputs the intensity modulation signal.

⑤ VIDEO OUT terminal

Outputs the color video composite signal displayed on the screen with NTSC format.

Readout Locations

· Contents of display

A	SWEEP	RATE	A TRIGGER SOURCE	A TRIGGER	A TRIGGER COUPLE	A TRIC		Swe magnifi		n H()LD OFF	`TIME
В	SWEEP	RATE	B TRIGGER SOURCE	B TRIGGER SLOPE	B TRIGGER	B TRIC	GGER EL·				DELAY	ΓIME
										F	JNCTION	MODE
Measurement of Δ V or Δ t											uency sured	
C	CH1 ¦Ra	112000	oup- ling ADD	CH2 INV	Range Cour	1 4 14 4	Range	Coup- ling	CH4	Range	Coup- ling	Bandwidth limiter

• An example of the display



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Menu

Selects the display conditions (DISP-MENU) and the setting of appendix functions (SYS-MENU).

1 Menu Tree



SYS-MENU

SAVE/RECALL MAX		
ORVDY REONDO MIN		66667.600
SGL SWEEP: AUTO ERASE	j	AUTO ERASE MANUAL ERASE
	Ľ.	······································
PROBE OFFSET:DISABLE		
ENHANCED INTEN ADJUST-		ADJUST: III III III III
AUTO BALANCE ADJUST		
AUTO DALANCE ADJUST		

EXIT

2 Setting f:DISP-MENU

Selects a color of READOUT, SCALE, CURSORS, PERSISTENCE, BACKGROUND. Adjusts brightness of READOUT, SCALE, CURSORS. Selects a measuring scale (GRID, AXIS, FRAME, EIA, CCIR).

2.1 Setting Items

COLOR BRIGHT READOUT : Selects the color of the characters. READOUT : Adjusts the brightness of the characters. SCALE SCALE : Adjusts the brightness of the scale. : Selects the color of the scale. CURSORS CURSORS : Adjusts the brightness of the measurement : Selects the color of the measurement cursor cursor and trigger cursor. and trigger cursor. PERSISTENCE : Selects the color of the persistent waveform. BACKGROUND : Adjusts the color of the background. : Adjusts brightness of LCD (Liquid Crystal Display). BACKLIGHT SCALE : Selects a measuring scale from GRID, AXIS, FRAME, EIA, CCIR.



DEFAULT

EXIT

: Defaults set up conditions (COLOR, BRIGHT, BACKLIGHT, SCALE) at the factory shipment. : Exit from the menu, return to measurement display.

RETURN

: Return to the upper menu as the left box.

2.2 Operation in the DISP-MENU

You can enable the menu operations by turning or pressing the [FUNCTION] pulse switch.

Turn [FUNCTION] : Selects, and adjust the menu item.

Press [FUNCTION] : Determines the menu item.

Entering to DISP-MENU

① Turn off all the functions to disable [FUNCTION] ¹¹.



- Condition that f:XXXX is not being displayed at the upper right of the screen (the delay time, number of TV lines, etc.)
 Press [FUNCTION] for 2 sec, then the display menu (f:DISP-MENU)
 - is appeared.

Selecting COLOR

(COLOR, BRIGHT, BACKLIGHT, SCALE, DEFAULT, EXIT) After procedure ④ are different by the selected item.



③ Turn [FUNCTION] to select COLOR and press it.



SPS CHI	+144	10	Ŋ₿∆.	f I B	ਸਹਾ ¢P	U% HENU
COLOR BRIGHT BACKLIGHT SCALE DEFAULT EXIT	SCA CUR PER	SORS SISTENC KGROUND	E	+ • • •		
SELECT :	8° 8 (]	•				
		ŧ	[ť	69.	547k

Selecting the READOUT

(READOUT, SCALE, CURSORS, PERSISTENCE, BACKGROUND)

- ④ Turn [FUNCTION] to select READOUT and press it.
- 5 Turn [FUNCTION] to select a color with SELECT: and press it.
- ◇ READOUT,SCALE,CURSORS,PERSISTENCE has 8 colors. BACKGROUND has 16 colors.

Return to previous menu screen

④ Turn [FUNCTION] to select RETURN and press it.



⑤ Turn [FUNCTION] to select EXIT and press it.

> KALIGHT Raight Backlight

10 nV.

ĎĚFÁŬLT Exit



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Adjusting the BRIGHT

(READOUT, SCALE, CURSORS)

④ Turn [FUNCTION] to select READOUT and press it.

⑤ Turn [FUNCTION] to select brightness with

(ADJUST: M M M D and press it.

Adjusting the BACKLIGHT

(5) Turn [FUNCTION] to adjust with (ADJUST: MEMMECOD) and press it.

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Setting the SCALE

⑤ Turn [FUNCTION] to select GRID or any and press it.

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3 Setting f:SYS-MENU

Setting the maximum register number of the SAVE/RECALL.Select ENABLE or DISABLE of the offset voltage for the FET Probe connected to terminal PROBE POWER. Adjusts the vertical balance automatically.

	No function disp	lay
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SAVE/RECALL HAX: 256	
ISGL SWEEP: BUTO ERBSE	
ISGL SWEEP: BUTO ERBSE	1
ENHANCED INTEN ADJUST.	1
AUTO BALANCE ADJUST.	-
(EXIT	
MANUAL ERASE	
15 100 ∎V 21 > 10 ∎V 10 ∎V	h

- ① Turn off all the functions to disable [FUNCTION] ".
 - ¹¹ Condition that f:XXXX is not being displayed at the upper right of the screen (the delay time, number of TV lines, etc.)
- ② Turn [READOUT] fully counter clockwise (no readout display).
- ③ Press [FUNCTION] for 2 sec, then the system menu (f:SYS-MENU) is appeared.
- SAVE/RECALL MAX

Set maximum number of panel settings (max 256).

SGL SWEEP: AUTO ERASE

AUTO ERASE : ERASE waveform automatically when SGL/RST is pressed.

MANUAL ERASE : Press [ERASE]. (Enables over-write)

PROBE OFFSET

ENABLE: Enables the offset voltage control of the FET Probe connected to PROBE POWER (P1/P2) terminal. (Refer to 28 pages to "PROBE P1/P2 Offset")

ENHANCED INTEN ADJUST

Intensity is preset in single sweep mode to get adequate brightness at any sweep condition and ranges.

ENHANCED INTEN ADJUST function slightly adjust the brightness as you like.

In the following cases, the trace brightness is set automatically.

- 1. When you press AUTO SET .
- 2. When you switch the sweep mode from AUTO or NORM to SINGLE.
- 3. When you vary the sweep rate (TIME/DIV) in single sweep mode.
- After above 3 conditions the brightness is set by turning the INTEN knob. Waveform that has already stored waveform.

AUTO BALANCE ADJUST

Adjusts the vertical trace shift when VOLTS/DIV is switched.

♦ Execute AUTO BAL ADJUST after warm up enough.

EXIT from the menu

④ Turn [FUNCTION] to select EXIT and press it.

Operation

Be sure the power switche	s to STBY position, before to connect or remove the power cord.
Use this instrument with th	e rated AC power supply.
Voltage range : 100 to	240 VAC
Frequency : 50/60	Hz
Power consumption: 140 V	A max.
Use a 3-core power cord m	eet to the supply voltage.
Do not place any object at	the air ventilation hole or exhaust fan of this instrument.
Use this instrument within	the rated operating range.
Temperature : 0 to +40 °C, hu	umidity : 90%RH (at 40 °C)
	his instrument even if the power switch is set to STBY. Disconnect the tacle if the instrument is not used for a long time.
Do not apply over rating vo	oltage to the input terminal.
CH1, CH2, CH3, CH4 inpu	t at 1 MΩ
Direct	: $\pm 400 \text{ V} (\text{DC+ACpeak}).$
•	ent : $\pm 600 \text{ V}$ (DC+ACpeak).
	: 5 Vrms ut voltage derates depending on frequency and high voltage pulse of an inpu ge 68 "PP005 PROBE").
signai (reier to pag	tterv
Built-in Lithium primary ba	
	-

Basic Operation

1 General

In order to understand the LA354 operations, CAL output and a signal generator are used. The signal generator is the Iwatsu FG-350.

\diamondsuit Setting when power is set STBY or OFF "

When power is set STBY or OFF, the panel setup before STBY or OFF is stored. When power is turned on again, the panel setup resume to before STBY or OFF. After power cord is disconnected (OFF), the built-in batteries back up the panel setup.

¹¹ The condition of the power cord is disconnected.

2 Displaying CAL Signal with AUTO SET

Allows you to display the waveform on the screen automatically in the appropriate conditions.

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Procedures

Turning power on

- ① Set **POWER** to **STBY**.
- ② Connect the power cord to the AC LINE INPUT on the rear panel and to the AC power source.
- ③ Press **POWER** to turn **ON** the power.
 - Traces, characters, or both are displayed on the screen.
- ④ Connect the CH1 input connector and CAL connector with the probe.
- 5 Press AUTO SET .
 - The CAL signal (1 kHz, 0.6 V square wave) is displayed on the screen.
 - When the input resistance is 50 Ω , the CAL waveform does not appear on the screen.

Press $50 \Omega/1M\Omega$ and select $1M\Omega$.

• When you activate the AUTO SET function by pressing the AUTO SET, you may not move the signal position by controlling position knobs in some range. In this case, rotate the [POSITION] [LEVEL] further until it will be in action again.



About the AUTO SET Function

- Press AUTO SET when you do not know "how to operate, amplitude or frequency of signal".
- The instrument check the amplitude and frequency of the input signal, automatically set the proper scope conditions (refer to the next page), and displays the waveform on the screen.
- · The proper scope conditions may not be found depending on the frequency, amplitude, or duty ratio of the
- input signal conditions.

Table 1 Setting conditions of AUTO SET

Vertical deflection system	Triggering
Deflection factor VOLTS/DIV : The frequency is between 50 Hz and 100 MHz, 2 mV to 5 V/div with amplitude of 1.5 to 8 div VARIABLE : OFF (CAL)	A/B : A SOURCE : Detected in the order of CH1 and CH2 COUPL : DC TV : When Last setup before AUTO SET is TV MODE, TV-H, NTSC, PAL, or
Display channel CH1 : Last setup before AUTO SET ¹¹ CH2 : Last setup before AUTO SET ¹¹ CH3 : OFF (non-display) CH4 : OFF (non-display) ¹¹ CH1 alone is set to ON if both CH1 and CH2 have been set to OFF.	HDTV is automatically set. When last setup is not TV-MODE, TV settings are skipped in spite of TV signal applying SLOPE : + ("-" in the case of TV mode) LEVEL : Around 0 div
POSITION	Horizontal deflection system
In case of 1-channel display : In the middle In case of 2-channel display CH1 : About + 2 div CH2 : About - 2 div	HORIZDISPLAY : A TIME/DIV : 50 ms to 10 ns/div, approx. 2 to 5 cycles of signal VARIABLE : OFF
AC/DC:Last setup before AUTO SET 2 $50 \Omega/1M \Omega$:Last setup before AUTO SET 3 GND:OFF (GND released)ALT/CHOP:CHOPCH2 INV:OFFBWL:OFF (no Bandwidth limiter)ADD:OFF	SWEEP MODE : AUTO POSITION : Sweep starts from a position near the left end of the screen. READ OUT : ON AINTEN : Brightness is set to enough level

*1 When both CH1 and CH2 are OFF, CH1 is set to ON.

*2 When this is set to DC, AC coupling is selected when the waveform is out of position control range.

*3 When this is set to 50Ω , $1 M \Omega$ is selected when the waveform is out of position control range. After $1 M \Omega$ is set, the setting of input coupling (AC/DC) becomes AC.

[Note] When an adequate amplitude cannot be detected, the following conditions will be set on that channel : VOLTS/DIV : 10mV/DIV

VOLIDIDIV	. 10111V/D1
50 Ω/1Μ Ω	: 1MΩ
AC/DC	: AC

3 Probe Compensation

Adjusts the waveform on the probe. Confirm that the waveform of the probe is compensated correctly before using the probe.

Procedures

Connect CH1 input terminal to CAL terminal over the attached probe.

1 Set this unit as follows:

CH1VOLTS/DIV: 10 mV

GND : OFF (GND released)

: CH1

- AC/DC : DC
- SOURCE

SEC : 200 µs

- ② Set [TRIG LEVEL] to get a stable display.
- ③ Adjust the variable capacitor of the probe by turning with a screwdriver for flatness response on square wave.

Correctly compensated waveform

- · Overcompensated waveform

- · Under compensated waveform

◇ Probe sense (display of deflection factor)

When the probe has a probe sense function, the voltage as compensated by the attenuation ratio of the probe is displayed.

◇ Releasing the loading effect by a probe

If a cable, etc. is directly connected to the circuit under measurement, observation may be disturbed by the load applied by the input impedance of the measuring equipment. The input RC of this unit is "1 M Ω , 16 pF". If a 10:1 probe is used, the input RC becomes "10 M Ω , 13 pF" and thus the loading effect is largely released enabling the measurement with a high accuracy.







Purpose of Using Probes

What problems will occur if a wire is connected directly from the input terminal of the oscilloscope to the circuit under test?

1)	Easily affected by noises.
2)	The frequency band width is reduced.
3)	Loading effect is large.
Problem 1)	Can be improved by the use of coaxial cable or shielded wire.
	By this method, however, problem 2) and 3) cannot be solved.
Problem 2)	When the wire is directly connected, the frequency band width is limited by the inductance and stray capacitance of the wire.
	The use of a 10:1 probe, however, can eliminate such influence.
Problem 3)	When the oscilloscope input is viewed from the side of the circuit under measurement, if the wire
	is connected directly, the capacitance and inductance constitute a load as is the case of problem 2).
	In this case, there is still a high load even if a shielded wire is used for connection.
Then, what will hap	ppen when a 10:1 probe is used?
	Let's compare the 10:1 probe and shielded wore.
	Probe : 1.5 m 10:1 probe with an input capacitance of 15 pF
	Shielded wire : 1.5 m total capacitance 150 pF (unit capacitance 100 pF/m)
	Oscilloscope : Input capacitance of 30 pF

Conclusion : Loading effect of the capacitance will be reduced from 180 pF (150+30) to 15 pF. The amplitude will be attenuated to 1/10.

4 Adjustment of the Screen (A INTEN, FOCUS, TRACE ROTATION)

Adjusts the brightness (A INTEN), focus (FOCUS), and rotation of traces (TRACE ROTATION).

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Procedures <u>A INTEN</u>

① Adjust the A sweep brightness of traces by turning [A INTEN].

FOCUS

② Adjust the focus of traces and displayed characters by turning [FOCUS].

TRACEROTATION

- ③ Set the input coupling of CH1 to GND by pressing GND.
- ④ Adjust the alignment of the trace to horizontal graticule by turning TRACE ROTATION on the front panel with the attached adjustment screwdriver.
- ⑤ Release the input coupling GND.

BINTEN

Turn [B INTEN] when adjusting the trace intensity of B sweep.

Refer to page 35 "Horizontal Display" for B sweep.

5 Vertical and Horizontal Position

Controls the vertical and horizontal position of the waveform.



Procedures

Moving vertical positions

- ① Turn [▲POSITION▼] of CH1 to the clockwise ; the waveform moves upward.
- ② Turn [▲POSITION♥] of CH1 to the counterclockwise ; the waveform moves downward.
- \diamond CH2 to CH4 are same as CH1.

[Example] Moving position and storing waveform.



Moving horizontal position

- ① Turn [◀ POSITION ▶] to the clockwise; the waveform moves to the right.
- ② Turn [◀ POSITION ▶] to the counterclockwise ; the waveform moves to the left.
- ③ When every time FINE is pressed, the FINE indicator lights or goes off.
 - When the Fine indicator is lighted, [◄ POSITION ▶] is fine adjustment mode. If [◄ POSITION ▶] is fully turned in fine mode case, the waveform scrolls. To stop scroll, return [◄ POSITION ▶] slightly.

6 Position Check

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Press [A INTEN (BEAM FIND)].

 A vertically and horizontally compressed wave form is displayed.

Vertical Deflection System

1 Deflection Factor

1:10mV 2:10mV

Display of deflection factor

1:)10mV 2:10mV

Indicates setting is uncalibrated

Sets the amplitude of waveform to a suitable size for viewing.

a. CH1 and CH2

Procedures

Setting the VOLTS/DIV

① Select the deflection factor by turning [VOLTS/DIV] of CH1.

- The deflection factor can be selected with a range of 2 mV/div to 5 V/div (in 1-2-5 steps).
- · The deflection factor is displayed at the lower left corner of the screen.

[Note] Perform AUTO BALANCE ADJUST if traces move upward or downward when the range is switched even if no signal. (refer to page 59 "Maintenance").

Setting the VARIABLE

- ② Press [VOLTS/DIV] of CH1 ; the deflection factor is displayed with ">" mark.
 - · Fine adjustment is available in this condition.
- ③ Turn [VOLTS/DIV] of CH1; the deflection factor varies continuously between steps.
 - · While [VOLTS/DIV] is turned, the rough ratio to the original range is displayed in percentage.
 - · To release the variable setting mode, delete ">" by pressing [VOLTS/DIV] again.
- \diamond CH2 is same as CH1.

b. CH3 and CH4

3:500 mV

Procedures

① Select the deflection factor by pressing 100 mV/500 mV of CH3.

· One of the two ranges of 100 mV/div, or 500 mV/div can be selected. Fine adjustment is not available.

 \diamond CH4 is same as CH3.





22
2 Input Coupling

Selects a suitable coupling mode for observation depending on the type of input signal.

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Procedures Selecting GND

- Press GND of CH1 and set GND to ON (the GND mark is displayed at the lower left corner of the screen).
 - The input of the vertical amplifier is connected to GND and a trace (grounding potential) is displayed.
 - · CH3, CH4 has no GND.
 - [Note] Perform AUTO BALANCE ADJUST if traces move upward or downward when the range has been switched (refer to page 59 "Maintenance").

Selecting DC or AC

- ① Press GND of CH1 and set GND to OFF (GND released).
- ② Press **DC/AC** of CH1 and set **DC** or **AC**.
 - When the input resistance is selected the 50 Ω , can not be set to AC.
 - When AC is selected the 50 Ω indicator goes off and the input resistance becomes 1M Ω .

- The DC and AC components of the input signal are displayed.
- The input signal is displayed on the basis of the GND level. [Example] The waveform include the DC component.



\diamond ac

GND

f‡25.

- Only the AC component of the input signal is displayed, and the DC component is cut.
- The input signal is displayed at the mean potential of signal.
- · The "~" mark is displayed over the character "V".
- · CH2 is same as CH1.

3 Input Resistance

Select the input resistance.



FOR 50 Ω, KEEP ON PRESSING

Procedures

① Depress $50\Omega/1M\Omega$ and select 50Ω or $1M\Omega$.

- To select 50 Ω , keep **50 \Omega/1M \Omega** pressed for a while.
- When the duration of pressing is too short, the left error message is displayed.
- When 50Ω is selected, the indicator lights.
- [Note] When 50 Ω is selected, the input coupling is automatically set to DC. AC cannot be set.

 \diamondsuit Use this unit with the input resistance set to 1M Ω in usual cases. \diamondsuit How to use 50 Ω

- When measuring the signals in a high frequency band, connect this unit and the signal source with a coaxial cable having a characteristic impedance of 50Ω .
- When the input resistance is set to 50Ω , the VSWR (voltage standing wave ratio) is 1.35 or less, so a waveform with few reflection can be observed.

1 Cautions

When the input resistance is set to $50\,\Omega$, do not apply excess signals of 5Vrms or more.

When a DC voltage of ± 10 V or more is detected, the following error message is displayed for protection and the setting is changed from 50Ω to $1M\Omega$.

"INPUT OVERLOADED AND REVERTED TO $1M\Omega$ "

4 Display Channels

Signals input to CH1, CH2, CH3 or CH4 are displayed.



Procedures

- ① Press CH1, CH2, CH3 or CH4 to select ON (display) or OFF (non-display).
 - [Example] CH1, CH2, CH3 and CH4 are set to ON is shown on the left.
- Every time the channel key is pressed,
 ON (display)/OFF (non-display) is selected alternately.

1:10mV

- The channel No., VOLTS/DIV, and input coupling of the channels set to ON are displayed in the lower left corner of the screen.
 The OFF channel disappear from the screen.
 - [Note] When all channers (CH1, CH2, CH3, CH4 and ADD) are set to OFF, CH1 is displayed.

5 ALT and CHOP

Allows you to select the display mode (ALT, CHOP) when two or more channels are displayed.





Procedures

- Select two or more channels from CH1, CH2, CH3 and CH4 (refer to above "Display Channels").
- ② Press **ALT CHOP** to select **ALT** or **CHOP** (the indicator lights).

♦ ALT (alternate)

- · Alternately two or more input signals are swept.
- This mode is suitable for observing high-frequency signals on two or more channels.

♦ CHOP (chop)

- The chopped switching rate (CHOP frequency) is approx. 555kHz.
- This mode is suitable for observing low-frequency signals on two or more channels.
 - [Note] When sweep times are faster than 20 μ sec/div, even if LED of CHOP lights, ALT sweep is selected as sweep mode.

6 Sum and Difference

Adds two channels (CH1 + CH2) or subtracts one channel from another (CH1 - CH2). Addition or subtraction can be selected by selecting ADD and then setting INV.



Procedures

- ① Set CH1 and CH2 to ON (display) (refer to page 25 "Display Channels").
- ② Press ADD to set ADD to ON ("+" is displayed in the lower left corner of the screen).
 - The sum of two signals (CH1 + CH2) is displayed on the screen.
- ③ Press INV to set INV to ON ("↓" is displayed in the lower left corner of the screen).
 - The polarity of CH2 is inverted and the difference between two signals (CH1 - CH2) is displayed on the screen.



7 Bandwidth Limiter

Bandwidth limiter reduces noises. The frequency band is limited to about 20 MHz or about 100 MHz.

Procedures

① Press **BWL** to select 100, 20, or OFF.

• The bandwidth is displayed at the lower right corner of the screen. There is no display when OFF is selected.



- OFF : No bandwidth limitation.
- 100 : The bandwidth is limited to 100 MHz.
- 20 : The bandwidth is limited to 20 MHz.

8 Offset

8.1 CH1/CH2Offset

Adjusts the CH1/CH2 offset voltage. DC OFFSET is used for measure AC signal superimposed on DC voltage at the DC coupling mode.





Offset Voltage



Procedures

Selecting the reference position

① Press GND to set GND to ON (refer to page 23 "Input Coupling").

- ② Turn [▲POSITION▼] to set the reference position for offset.
 - An example of setting the reference position is shown on the left.

Selecting the offset voltage

- ③ Press GND to set GND to OFF.
- ④ Press **DC/AC** to select DC.
 - When the input coupling is set to AC, the display is followed by "?" mark.
 - · The trigger level value does not include the offset value.
- ⑤ Input AC signals included DC offset to the input terminal (CH1, CH2)
- 6 Press OFFSET to select the OFFSET channel of CH1 or CH2.
 - · Function display changes into f:OFFSET CH1.
- ⑦ Set the offset VOLTAGE (CH1/CH2) to the reference position by turning [FUNCTION].
 - The reference position set in procedure ⑦ becomes the offset voltagevalue.

⑧ Turn [FUNCTION] to magnify the waveform.

When **[FUNCTION]** is turned clockwise, the trace moves downward and the voltage display varies in the positive direction.

- \diamondsuit Selecting the object channel
 - The channel as the object of setting (CH1 or CH2) can be selected by pressing **ATTACH**.
- ◇ Releasing CH1/CH2 offset

Select OFF (without the display of OFFSET) by pressing **OFFSET**.



• OFFSET allows you to magnify the small AC signal included a big DC offset.

- If the input signal is measured with AC input coupling and turning [▲POSITION▼] fully counterclockwise, you cannot obtain enough magnifying rate and measuring the variation of the low frequency (4Hz or less).
- OFFSET voltage allows you to set within the range from zero volt to $\pm 100V$, $\pm 10V$ and $\pm 1V$ (depend on range).

8.2 PROBE P1/P2 Offset

Sets the offset voltage of the FET probe which is connected to the PROBE POWER terminal (P1/P2) of this unit. DC OFFSET is used for measure AC signal superimposed on DC voltage at the DC coupling mode. The lower frequency signal can be measured without any distortion.

 Turn off all the function to disable [FUNCTION] ''. '' Condition that f:XXXX is not being displayed at the upper right the screen (the delay time, number of TV lines, etc.) '' Press [FUNCTION] to select OFF (non-display). '' Press [FUNCTION] for 2 sec, then the system menu (SY3 MENU) is displayed. '' The left figure is displayed on the screen. '' Turn [FUNCTION] to Select PROBE OFFSET. '' Press [FUNCTION] to Select PROBE OFFSET. '' Press [FUNCTION] to display boxed ENABLE/DISABLE. ENABLE : The offset voltage can be set. DISABLE : The offset voltage cannot be set. '' Press [FUNCTION] to select ENABLE. Function display → f:OFFSET P1 Percent display Percent display Percent display Percent display '' Press [FUNCTION] to select EXT. The settings are maintained after power is turned off. Setting PROBE offset '' Press [OFFSET P1. '' Function display changes into f:OFFSET P1. '' Press [OFFSET P1. '' The set offset voltage (P1/P2). 	No function display →	•	Selecting on SYS-MENU
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Image: Imag			-
Function display → f:OFFSET P1 ← Cancels SYS-MENU			-
Function display → f:OFFSET P1 ← Cancels SYS-MENU (⑤) Press [FUNCTION] to select EXT. The settings are maintained after power is turned off. OFFSET ← Setting PROBE offset ① Press [OFFSET] (○) Press [FUNCTION] to select OFFSET P1/P2. ← Function display Percent display P1:100.0% P2:20.00% ← Function display changes into f:OFFSET P1/P2. ← Function display changes into f:OFFSET P1. ② Turn [FUNCTION] to set the offset voltage (P1/P2). • This is the ratio (%) to the offset variable range of the FET probe • This is valid with the SFP-5A/4A probe made by lwatsu. ◇ Selection of the object terminal The terminal as the object of setting (P1 or P2) can be selected I pressing [ATTACH]. ET probe A probe with an FET attached to the tip is called an active probe. • • This is a probe with a high impedance and low input capacitance. • When a probe for common oscilloscopes is connected, the signal under test may be affected (such as oscillation) by the input capacitance of the probe.			b Press [FUNCTION] to select ENABLE.
 Function display → f:OFFSET P1 Percent display Percent display<	00 + +0.0000 k		
Function display + f:OFFSET P1 + The settings are maintained after power is turned off. Percent display Percent display Percent display Percent display P1:100.0% P2:20.00% + Function display changes into f:OFFSET P1/P2. · Function display changes into f:OFFSET P1/P2. · Function display changes into f:OFFSET P1/P2. · · Function display changes into f:OFFSET P1/P2. · Function display changes into f:OFFSET P1/P2. · · · Function display changes into f:OFFSET P1/P2. · · · Function display changes into f:OFFSET P1/P2. · · · Function display changes into f:OFFSET P1/P2. · · · Turn [FUNCTION] to set the offset variable range of the FET probe · · This is the ratio (%) to the offset variable range of the FET probe. · The terminal as the object of setting (P1 or P2) can be selected in pressing [ATTACH]. ET probe A probe with an FET attached to the tip is called an active probe. · This is a probe with a high impedance and low input capacitance. · When a probe for common oscilloscopes is connected, the signal under test may be affected (such as oscillation) by the input capacitance of the probe.<			Cancels SYS-MENU
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Input impedance \pm 1 M Ω , approx. 1.9 pF (SFP-5A)/1 M Ω , approx. 2.15 pF (SFP-4A) Attenuation ratio \pm 10:1			
Attenuation ratio : 10:1			
Bandwidth : DC to 1 GHz (SFP-5A)/DC to 800 MHz (SFP-4A)	the second se		

Horizontal Deflection System

1 Triggering

This is the basic operation to get a stable waveform on the screen.

1.1 Trigger Source

Selects the trigger source. Select B trigger when HORIZ DISPLAY is ALT or B. (Refer to 41 pages to "Delayed sweep")

A trigger source	Procedures
↓	 ① Press A B to select A trigger or B trigger (the indicator lights).
5 ms CH1	 B trigger is set when performing a triggered delay (refer to page
^I 1 ms CH1 ↑	42 "Triggered Delay".
B trigger source	② Press SOURCE to select the trigger source (CH1, CH2, CH3, CH4 or LINE).

• Line is for A sweep only.

CH1 : The CH1 input signal is used as the trigger source.

CH2 : The CH2 input signal is used as the trigger source.

CH3 : The CH3 input signal is used as the trigger source.

CH4 : The CH4 input signal is used as the trigger source.

LINE (A sweep only) : The power line signal is used as the trigger source. This is suitable for line frequency synchronized signal observation.

1.2 Trigger Coupling

Selects the trigger coupling.

A trigger coupling	 Procedures → ① Press A B to select A trigger or B trigger (the indicator lights).
5 ms CH1 + AC	B trigger is set when performing a triggered delay (refer to page
' 1 ms CH1 + AC ↑	42 "Triggered Delay".
B trigger coupling	② Press COUPL to select the trigger coupling (AC, DC, HF REJ or
	LF REJ).

AC	: AC coupling.	Eliminates the DC component of the trigger signal source. A lower limit of frequency is
	10 Hz.	

DC : DC coupling. Applies a trigger with a signal including all frequency components.

- HF REJ : Low-pass filter coupling. Applies a trigger by attenuating the frequency component beyond 10 kHz. Use when a high-frequency noise is included in the trigger source and the trigger is unstable by that noise.
- LF REJ : High-pass filter coupling. Applies a trigger by attenuating the frequency component below 10 kHz. Use when a low-frequency noise (hum of the line frequency, etc.) is included in the trigger signal source and a trigger signal is unstable by that noise.

1.3 Trigger Slope (SLOPE)

Selects at the positive or negative slope.



+ (Triggered at the positive going waveform portion)

1.4 Trigger Level

Adjusts the trigger level(voltage at the trigger point).

A trigger level

+÷924128

Procedures

- ① Press **AB** to select A trigger or B trigger (the indicator lights).
 - B trigger is set when performing a delayed sweep (refer to page 42 "Triggered Delay".

- (Triggered at the negative going waveform portion)

② Turning [TRIG LEVEL] to adjust the trigger level.

- The TRIG'D indicator lights when the trigger signal is generated.
- Sometimes "?" is displayed at the right of the trigger value displayed. This indicates that value is not exact when AC coupling or VARIABLE is set.

Trigger cursor

- While "A" or "B" trigger is setting, the trigger level cursor is displayed about 2 seconds.
- Triggercursor
 - Trigger cursor display conditions are as follows :
 - Trigger source : CH1, CH2, CH3 or CH4 Trigger coupling : DC or HF-REJ
 - The "B" trigger cursor for ALT sweep is not displayed.







Turning [TRIG LEVEL] to left from the midrange



1.5 TV Trigger

1.5.1 TV Format

Sets the TV format.



① Every time pressing **TV** selects the TV-Coupling.

$$BOTH \rightarrow ODD \rightarrow EVEN \rightarrow TV-H \rightarrow OFF$$

② Turn [FUNCTION] to select NTSC, PAL (SECAM) or HDTV.

· Refer to page 32 "Table 2 TV formats and their features" for the details of TV modes.

1.5.2 TV-V Trigger (BOTH, ODD or EVEN)

Selects the TV-V trigger mode from BOTH, ODD or EVEN. Additionally it can select a line number by turning [FUNCTION]. The function display changes into f:TV-LINE.



Procedures

① Select BOTH, ODD or EVEN by pressing TV. 2 Turn [FUNCTION] to select a line number.

- The sweep starts from setting number point.
 - · For coarse adjustment, press [FUNCTION].

- 100

. คก

- The setting range is shown in Table 3 Range of line number.
- ODD : The sweep starts by selected number of horizontal synchronization signal of the odd-numbered field.
- EVEN : The sweep starts by selected number of horizontal synchronization signal of the even-numbered field.
- BOTH : The sweep starts by selected number of horizontal synchronization signal of the odd-numbered or evennumbered field.

CCIR SCALE

- TV-H : The sweep starts by horizontal synchronization pulse.
- OFF : The TV mode is released.

EIA SCALE





1: 200 eV

10PS CH1 -TV-H NTSC

HO

Triggering on a horizontal synchronization pulse. The composite video signal between one horizontal can be observed by changing the sweep time to $10 \ \mu$ s.

Table 2 TV formats and their features

Format	Number of scanning lines	Field frequency	Video signal bandwidth	Countries	Remarks
NTSC	525	Approx. 60 Hz	4.2 MHz	U.S.A., Canada, Japan	
SECAM	625	Approx. 50 Hz	6 MHz	France, Russia	
PAL	625	Approx. 50 Hz	5 MHz	Europe, etc.	
HDTV	1125	Approx. 60 Hz	20 MHz		High definition TV

Table 3 Range of line number

Format -	Number of lines							
i Unnat	вотн	ODD	EVEN					
NTSC	1 to 525	1 to 263	264 to 525					
PAL (SECAM)	1 to 625	1 to 313	314 to 625					
HDTV	1 to 1125	1 to 563	564 to 1125					

[Note] The line number is counted by M mode in NTSC, is not by M mode in PAL (SECAM). M mode : Sequential numbers are assigned to scanning lines from after the start of the vertical blanking period.

Other modes than M: The line number 1 is set to the start point of the vertical synchronizing signal of the first field.

1.5.3 TV Clamp

2 S CH1 -TV-V PA

Clamps the back porch of composite signals to the reference level (ground level). This procedure enables stable observation of those TV signals without the average voltage fluctuation.



① Select the Formats by pressing **TV**.

- Refer to page 31 "TV Trigger" for TV modes.
- 2 Select the clamp (CLAMP CH1, CLAMP CH2, OFF) by pressing EVENT/TV CLAMP .
 - The selected clamp is displayed at the bottom of the screen. Shows the example of CLAMP CH1. CLAMP CH1 : CH1 is clamped.
 - CLAMP CH2 : CH2 is clamped. OFF
 - : Clamp is released.

40 1: 200 aV

- 100

- 80

-60

- 40 20

[Note 1] During the V synchronizing period of HDTV, waveform may be distorted due to the disabled clamp operation.

[Note 2] The reference level may not become stable if the TV signals are not synchronized.

[Note 3] The clamp level is ± 1 div or less from GND.



32

1.5.4 TV Scale

See page 11 "Setting Item" for detail.



1.6 Event Trigger

Selects the event trigger (count or burst).

		.1#S	CH 1 CH 1	+A0 +A0		26. 24	2 mV? DmV?	<	HU:	0%	
5								çoği	IT.	. 20	
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,					1-1-4-1				++++	****	
	seevi	Uma e	بالمالي 2		Ting 1				1.25.3		0
	and a second		1	÷				i i i i			
	5	l∎V				ŀ		f	2.5	440 k	łz



Procedures

set automatically.

set automatically.

 $V2=\bigcirc\bigcirc$ IRE is displayed.

 \Diamond Voltage sensitivity is displayed in ratio.

- ① Set the TV trigger mode to OFF.
 - Refer to page 31 "TV Trigger" for the setting method.
- 2 Press EVENT/TV CLAMP to select COUNT, BURST, or OFF.

 \Diamond When the EIA scale is selected, input 1V = 140 IRE (full scale) is

 \Diamond When the CCIR scale is selected, input 1V = 100 IRE (full scale) is

 \Diamond When VARIABLE is selected in cursor (Δ V) measurement, Δ V1/

Voltage sensitivity display : X1

Voltage sensitivity display : X1

[Example] $1/50 \cdot \cdot \cdot \times 1 \cdot \cdot \cdot \times 50$

• Operations after procedure ② vary depending on the item selected.

When COUNT was selected

· Function display changes into f:EVENT.

③ Turn [FUNCTION] to set the number of counts.

- The range of the number of counts that can be set is 1 to 65535.
- Refer to the following page for the details of count trigger.

When BURST was selected

Function display changes into f:EVENT.

④ Turn [FUNCTION] to set the Burst signal interval.

- The setting time range is 0.18 μ s to 9.99 s.
- Refer to the following page for the details of burst trigger.

When OFF was selected

Quit from event trigger.

33

Count

This function is suitable for checking a counter circuit and so on.

An B trigger is effective when the specified number of B trigger signals have been counted after the A trigger. [Example] An example where the count is set to 6 is shown below.



Burst

This function is suitable for observing a burst waveform.

An A trigger is effective for trigger signal after specified time interval.



2 Horizontal Display



2.1 Horiz Display

Select the horizontal display A, ALT, B or X-Y.



f‡950,81

1)....10mV

Procedures

- Select A, B, ALT or X-Y by pressing A, B or X-Y of the HORIZ DISPLAY mode.
 - Press A and B simultaneously to select ALT.

 \diamond A

A sweep is displayed.

◇ в

B sweep (expanded waveform in ALT) is displayed. Refer to page 41 "Delayed Sweep" for details.

\diamond ALT.

- A sweep (not expanded waveform) and B sweep (expanded waveform) are displayed simultaneously.
- Refer to page 41 "Delayed Sweep" for details.
- Vertical position of B sweep can be adjusted. B sweep is moved upward with respect to A sweep (refer to page 36 "Trace Separation").

🔷 X-Y |

- An X-Y display as CH1 input is the X axis and any channel (CH1, CH2, CH3, CH4, ADD) is the Y axis is displayed.
- This mode is used for hysteresis curves, lissajous waveforms, etc.
 - CH1 : Sine waveform approx. 950 Hz
 - CH2 : Sine waveform approx. 1900 Hz

2.2 Trace Separation

20PS

In ALT sweep node, control the B-sweep waveform position.

f†74.285

Procedures

Setting ALT sweep

① Set ALT by pressing **A** and **B** of the HORIZ DISPLAY mode.
• A-sweep waveform and B-sweep waveform are overlapped.

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		10) - 100 p		-			History			
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		1 		•••••					<u></u>	
									294 k	l

Setting TRACE SEP

② Press **DELAY/TRACE SEP** to select TRACE SEP.

• The function display changes as f:TR-SEP.

Control B waveform position

- ③ Set the vertical position of the B-sweep waveform by turning [FUNCTION] (only upward setting is available).
 - When pressing or depressing the [FUNCTION], coarse adjustment is available.

♦ The further coarse adjustment is available by turning while depressing.

3 A Sweep and B Sweep

Selects A sweep or B sweep.



Procedures

- ① Select ALT or B HORIZ DISPLAY.
- ② Select A or B by pressing **A B**.
 - The indicator lights when B is selected.
 - A : For setting the sweep rate and trigger for normal sweep
 - B : For setting the sweep rate and trigger for delayed sweep

\diamond Select A for setting the following items.

- A sweep rate
- Trigger signal source for A trigger
- Trigger slope for A trigger
- Trigger coupling for A trigger
- Trigger level for A trigger

\diamondsuit Select B for setting the following items.

- B sweep rate
- Trigger signal source for B trigger
- Trigger slope for B trigger
- Trigger coupling for B trigger
- Trigger level for B trigger

Sweep rate Slope Level Signal source Coupling A 5ms CH1 + DC 200mV B 1ms CH1 - AC 20mV

А	5ms	CH1	+	DC	200mV
В	1ms	CH1		AC	20mV
/	Signal Signal	† sourc		T Joupli	

4 Sweep Rate and Magnification

4.1 Sweep Rate

A sweep

Selects the sweep rate (TIME/DIV) of A sweep or B sweep.

Procedures

Selecting A/B sweep

A 500PS B 500PS A 5

① Press **AB** to select A sweep or B sweep (the indicator lights).

Setting the TIME/DIV

- ② Turn [TIME/DIV] to select the sweep rate.
 - The sweep rate is displayed at the upper left corner of the screen.
 - The waveform is magnified or shrunk on the basis of the sweep start point.
 - Proceed to step ③ to set variable adjustment (A sweep only).

Setting the VARIABLE

- ③ Press [TIME/DIV]; the variable sweep rate is displayed at the upper left corner of the screen.
- ④ Turn [TIME/DIV]; the sweep rate varies continuously between steps.
 - "VAR LIMIT" is displayed when the set value reaches the maximum or minimum value.
 - · To release the variable setting mode, press [TIME/DIV] again.

4.2 Magnification (MAG x 10)

A 2.69 ms CH1 + DC

Variable 1ms to 3 ms (at 1ms/div)

1

Magnifies the waveform by 10 times from the center of the screen to the left and right.



Center line (magnification reference point)

Procedures

- Set the portion of the waveform to be magnified to the center of the screen with horizontal [◀ POSITION ►].
- 2 Press x 10 MAG .
 - The sweep rate is set to 10 times faster and the waveform is magnified to the left and right from the center line of the screen.
 - MAG is displayed at the upper right corner of the screen.

4.3 CH2 Delay Adjust (CH2 DLY)

When measuring the time difference between two signals, preliminary adjustment of the scope's CH1 and CH2 time difference enables highly accurate measurement. The available adjustment range (including the two connection cables) is within 1nsec.

Connection

Connect cables as follows :



Procedures

- (1) Set input resistance to 50Ω of CH1 and CH2.
- ② Set A sweep rate to 5 ns/div or 500 ps/div (x 10 MAG ON).
- ③ Select ALT by simultaneously pressing **A** and **B** of HORIZ DISPLAY.
- ④ Overlap the CH2 waveform to the CH1 waveform by turning [FUNCTION].



Waveform before the adjustment



♦ Waveform after the adjustment

5 Sweep Mode

Selects the sweep mode (AUTO, NORM or SINGLE).

5.1 Repetitive Sweep

Selects AUTO or NORM.

Procedures

① Select repetitive sweep by pressing AUTO or NORM in the SWEEP MODE.

- · The AUTO indicator lights when AUTO is selected and NORM indicator, when NORM is selected.
- If triggering is not stable, adjust [TRIG LEVEL], etc.
 Refer to page 29 "Triggering" for details.

AUTO (automatic sweep)

- If no trigger signal, the sweep freeruns.
- When the trigger signal frequency is approx. 10 Hz at a sweep rate between 500 ms and 10 ms/div, or less than approx. 50 Hz at a sweep rate of 5 ms/div or faster, triggering may be unstable. In this case, change to NORM.

NORM (normal sweep)

- If a new trigger does not occur, sweep stops.
- Only when the trigger source is CH1 or CH2 and the input coupling is GND, the sweep start freeruns for trace identification.

5.2 Single Sweep

Only once sweeps when a trigger signal is applied next trigger signals are ignored till set to ready. "Pressing ERASE" can erase the displaying waveform.

[Note] In single sweep condition, the storage mode is always set to storage.

Procedures

① Select single sweep by pressing SGL/RST in the SWEEP MODE (the SGL/RST indicator lights).

- The READY indicator lights to indicate the state waiting for trigger signal.
- \diamond Sweep is starts once when a trigger signal is applied.
- The READY indicator goes off.
- In the CHOP mode, all channels are swept simultaneously (500ms to 50 μ s).
- In the ALT mode, every time a trigger signal is applied, the sweep channel is changed sequentially as CH1 → CH2 → CH3 → CH4.

② To start the single sweep again, press SGL/RST .

6 Delayed Sweep

Selects the delayed sweep mode (continuous delay, triggered delay).

6.1 Continuous Delay

B sweep starts after a specified delay time period from the A sweep start point. The specified portion of the waveform is displayed as a expanded waveform. This function is valid when HORIZ DISPLAY is set to ALT or B.



Procedures

Selecting ALT sweep

① Select ALT by pressing **A** and **B** in the HORIZ DISPLAY mode.

- A sweep and B sweep are displayed.
- The intensity-modulated portion of A sweep (in the lower area of the screen) is expanded and displayed as B sweep (in the upper area of the screen).
- B sweep is separated from A sweep for convenience of explanation. For the method of separation, refer to page 36 "Trace Separation".

Selecting the B-sweep rate

- ② Select B by pressing AB (the B indicator lights).
- ③ Select the B-sweep rate by turning [TIME/DIV].
 - The ratio between A sweep and B sweep varies.
 - The B-sweep rate cannot be set slower than the A-sweep rate.

A 5ms CH1 + DC A level B 1ms - AC B level No display of trigger source B

Delay time - DLY nnn

← ④ Select the B trigger source to blank on the screen display by pressing SOURCE.

Selecting the delay time

Selecting of continuous delay

- 5 Select DELAY by pressing DELAY/TRACE SEP .
 - · Function display changes into f:B-DELAY



The intesified portion moves continuously

- 6 Adjust the delay time by turning [FUNCTION].
 - When pressing or depressing the [FUNCTION], coarse adjustment is available.

6.2 Triggered Delay

A 5ms CH1 +

B 1msCH1 -

Trigger source B

DC A level

AC Blevel

Triggers the B sweep with the trigger signal after the specified delay time. The triggered delay reduce the delay pick off jitter of the continuous delay.

Procedures

1 to 3 same as those in page 41 "Continuous Delay".

Selecting of trigger delay

4 Select trigger source B by pressing **SOURCE**.

Triggering of B sweep

5 Trigger B sweep by turning TRIG LEVEL .

 The method for triggering is the same as that for A sweep (refer to page 29 "Triggering").



Selecting the delay time

6 Select DELAY by pressing DELAY/TRACE SEP . · Function display changes into f:B-DELAY.

- ⑦ Adjust the delay time by turning [FUNCTION].
 - · When pressing or depressing the [FUNCTION], coarse adjustment is available.
 - · Although the DLY value varies continuously in trigger delay mode, it does not show the actual delay time, and it is added the ">" mark.

The intensified portion moves to the next trigger point.

6.3 Selecting B ENDS A

sweep

Terminates the A sweep at the end of B sweep.

The sweep length is shortened after the intensified portion (B trace) of the A trace.

The sweep repetition rate is increased by deleting A sweep time, and brightness is increased.



Procedures

① Select HOLDOFF by pressing HOLDOFF.

· For details of HOLDOFF, refer to page 43 "Holdoff".

2 Set the hold-off time to a value larger than 100% by turning [FUNCTION] ; the B ENDS A mode is set.



7 Holdoff

Sometimes stable triggering cannot be abtained when observing a complex pulse train. In this case, adjust the holdoff (sweep halt) time so that a stable waveform can be obtained.



- The holdoff time becomes the maximum value (100%) when
 [FUNCTION] is fully turned clockwise, and the minimum value
 (0%) when fully turned counterclockwise.
- Usually, the holdoff time is set to 0%.





Waveform before adjustment (not one trace)

Waveform after holdoff adjustment

Adjustment of the hold-off (sweep halting) time

Adjust the period from the end of sweep to the ready to trigger (hold-off time) so as to prevent any triggering by an unnecessary trigger signal.

Storage

TS-8500 has 5cm/ns ultra high writing speed by using newly developed CCD type scan converter tube.

1 Scan Converter Tube

Electron beam from the cathode is deflected by the vertical and horizontal deflection plates, and expanded by box lens, finally reach to the screen then a waveform is drawn and visible.

The drown waveform is captured by CCD (Charge Coupled Device) over OFP (Optical Fiber Plate).

The OFP is bundle of many thin optical fibers, for isolation of the screen potential (+20kV) to the CCD potential (zero voltage) and for getting clear waveform without diffusion.



♦ Beam density

The drawing area of the screen is approximately 10mm×8mm.

Conventional oscilloscope has 10cm×8cm display-area.

From simple calculation the ratio of electron beam density is 100 times.

Distance

Distance between the drown waveform and CCD is very close about 10mm.

Usually the distance between normal oscilloscope and eye is about 30cm.

The ratio of brightness is calculated 30 powered 2 equal 900.

Total brightness ratio

Total ratio of brightness is 100 times \times 900 times equal 90000.

But sensitivity of CCD and loss of OFP affect to reduce the number of ratio.

In conclusion, scanning converter tube has 20000-30000 times brightness.

\diamond What is writing speed?

This guide number is similar to signal shot bandwidth of CCD.

It express storage ability of how high frequency or fast transition signal.

TS-8500 has 5 div/ns writing speed, the unit div/ns shows electron beam moving speed of CRT.

When the 500 MHz sine wave is input, up to 3.18 div amplitude (Peak-Peak div) is stored. The calculation is as follows.

Ws=A π f. (The speed in the point that the sine wave crosses 0° 180° and 360°)

Ws:(Writing speed) A:Amplitude (Peak-Peak) π :3.14 f:Frequency (Hz)

 $5 \text{ div/ns}=5 \times 10^9 \text{ div/s}$

 $5 \times 10E9 = A[div] \times 3.14 \times 500 \times 10^{6} A = 3.18[div]$

Pulse

The pulse transition is assumed to be a straight line, Tr is defined the time from 10% to 90% of amplitude. So amplitude of pulse is supposed to A. Tr=rise time A=1.25×Ws×Tr

Pulse 1.27 0.64 Rise time [ns] 2.5510.0 8.0 7.0 6.0 5.0 4.0 3.2 P-P Amplitude(DIV) Relation of writing speed and amplitude Sine WS= $\pi \times Af$ $A=WS/\pi f$ Pulse WS=A/($1.25 \times sTr$) A=WS($1.25 \times Tr$) 2.0 1.0 100 200 400 500 800 Sine

2 Inherent Phenomenon of Scan Converter Tube Smear

Figure A



As shown in figure A, the pseudowaveform appears because of over brightness of the trace when the repeated signal is observed in slow sweep rate. It is called a smear, The smear is inherent of CCD (Charge coupled device) used for the scan converter tube.

1600

Frequency MHz

Writing Speed and Amplitude

Distortion on the tube

As shown in figure B, some trace shift are recognized at some parts of the LCD screen.



Those are called Shear distortion, and not failure of the scope. Shear distortion is caused by the O.F.P (Optical Fiber plate) used for the scan converter tube.

TFT(thin film transistor) color liquid crystal display is carefully made by high technology. It has some defects such as some non-light points and always lighting points.

3 Storage Operation

 \diamond Storage : There are three ways of the storage operations to store the measuring signal.

Storage Operation	Persistence Time	Channels	Sweep Mode	Measuring Example
1.[PERSISTENCE]	Infinite persistence	1 to 4	AUTO/NORM	Jitter signal, intermittent noise
	Variable persistence	1 to 4	AUTO/NORM	Slow repetition rate signal
2.[STORAGE]	Infinite persistence 1	1 to 4	AUTO/NORM	Waveform comparison
3. [SINGLE]	Infinite persistence **	1	SINGLE	Single shot signal

- \diamond "PERSISTENCE time is set to infinite automatically, no adjusting available.
- [PERSISTENCE] : The persistence time of the displayed waveform can be adjustable.
 Infinite persistence : Keeps the stored waveform by turning [PERSISTENCE] fully clockwise.
 Variable persistence : The stored waveforms fade out gradually by determined persistence time.
- [STORAGE] : Current and stored waveforms are displayed simultaneously.
 It is convenient to compare both waveforms.
- ERASE
 Erases the STORAGE or PERSISTENCE waveform. When AUTO ERASE is selected in the [SINGLE] mode, stored waveform is erased by whenever SGL/RET is pressed.



- 3.1 Measuring in [PERSISTENCE] Display
- a. Measuring of jitter signal (infinite persistence)



Procedures

- ① Turn [PERSISTENCE] to fully clockwise.
- ② Select AUTO or NORM of SWEEP MODE.
- ③ Set [A INTEN] to get the adequate trace intensity.
 - [Example] The fractured frequency.

b. Low repetition rate signal (variable persistence)



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Procedures

- ① Set SWEEP MODE to NORM .
- ② Set [A INTEN] to get the adequate trace intensity.
- ③ Set [PERSISTENCE] to get the adequate persistent trace time.
- 4 Repeat procedure 2 and 3.
- \diamond Press [ERASE] to erase the waveform.
 - [Example] Approx 2.5 Hz sine wave is measured by infinite persistence time.

The entire waveform is remained.

• [Example] Approx 2.5 Hz sine wave is measured by minimum variable persistence(fully counterclockwise).

Only short tail of sweep spot is displayed since there is short persistence time.

3.2 Measuring with [STORAGE]

Allows you to store the all trace on the screen.



Waveform comparison

Procedures

- ① Set SWEEP MODE to NORM .
- ② Set [A INTEN] to get the adequate trace intensity.
- ③ Press [STORAGE] to store the waveform.
- ④ [Example] This waveform are stored by changing [▲POSITION▼] and [TIME/DIV].
- (5) Whenever [STORAGE] is pressed, the all current sweep trace on the screen is stored.
- \diamond STORAGE is displayed at the under right of the screen.
- ◇ [ERASE] : Erases the STORAGE character and the waveform. Press [ERASE] then STORAGE and STORED waveform are disappeared.

3.3 Measuring in [SINGLE] Sweep Mode

In single sweep condition, the storage mode is always set to storage. The value of intensity is set automatically to get proper brightness after TIME/DIV is changed. If you want to control the brightness, turn [A INTEN], the brightness is controlled.

If automatic brightness setting is not proper, the value is adjusted by "AUTO INTEN ADJUST" of the system menu (Refer to page 14 "Setting of SYS-MENU").

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AUTO BALANCE ADJUST.	+
ADJUST : REEE	
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Capturing the single shot signal Procedures

- ① Press SGL/RST to select single sweep in the SWEEP MODE (the SGL/RST indicator lights).
 - The READY indicator lights to indicate the state waiting for signal input.
- \diamond A sweep runs once when a trigger signal is applied.
 - The READY indicator goes off after the sweep ends.
 - After the sweep ends, **STOP** is displayed at the lower right of the screen.
 - In the CHOP mode, all channels are swept simultaneously (500 ms to 50 μ s).
 - In the ALT mode, every time trigger signal is applied, one channel is swept sequentially.
- \Diamond Press [ERASE] to erase the waveform.
- ② Press SGL/RST to set the scope ready again.
 - Figure is a single sweep waveform with pulse width approx 2.0 ns and TIME/DIV is 1 ns/div.
- [Example] When TIME/DIV is faster than 20 μ sec/div ,the scope sets ALT even if LED of CHOP indicator lights.

ERASE by SINGLE (single sweep)

AUTO ERASE : ERASE occurs automatically whenever **SGL/RST** is pressed.

MANUAL ERASE : Press [ERASE]. (Enables over-write.)

Counter and Cursors Measurement

Measures the time difference and frequency (Δt , $1/\Delta t$) or voltage difference (ΔV) using cursors.



- \diamond Selecting of the measurement item
 - Select ΔV (voltage measurement) by pressing ΔV or select Δt (time measurement) by pressing Δt .
- ♦ Methods of cursors measurement
 - When Δt or ΔV has been selected, two cursors for measurement are displayed.
 - When pressing or depressing the [FUNCTION], coarse adjustment is available.

1 Time Difference (Δt) and Frequency (1/ Δt) Measurement

Measures the time difference (Δt) and frequency (1/ Δt) between the cursors.



Procedures

① Press Δt to select Δt .

- H cursor 1 and H cursor 2 are displayed.
- The value of Δt (time difference) and $1/\Delta t$ (frequency) between cursor 1 and cursor 2 are displayed at the lower left corner of the screen.

Setting cursor 1

2 Press TCK/INDEP to select C1 (cursor 1).

- The function display changes into f: H-C1.
- Symbol " I " displayed above H cursor 1 indicates that H cursor 1 is active.
- ③ Turn [FUNCTION] to set H cursor 1 () position.



2 Voltage Difference (∆V) Measurement

Measures the voltage between the cursors.



Procedures

- ① Press ΔV to select ΔV .
 - V cursor 1 and V cursor 2 are displayed.
 - The value of ΔV1 (CH1) and ΔV2 (CH2) between cursor 1 and cursor 2 are displayed at the lower left-hand corner of the screen.

Symbol representing an active cursor



Setting cursor 1

- 2 Press TCK/INDEP to select f:V-C1.
 - The function display changes into f:V-C1.
 - Symbol "—" appears to the left of V cursor 1 indicating that V cursor 1 is movable.
 - ③ Turn [FUNCTION] to set V cursor 1 (----) position.
 - V cursor 1 and V cursor 2 move simultaneously.

Setting cursor 2

- ④ Press **TCK/INDEP** to select f: V-C2.
 - The function display changes into f : V-C2.
 - Symbol "—" appears to the left of V cursor 2 indicating that V cursor 2 is active.
 - 5 Turn [FUNCTION] to set V cursor 2 (-----) position.



ΔV1=59.2 mV ΔV2= - 0.592 Hz 🖌



- The results of measurement of the voltage differences between the newly set cursors are displayed in the lower left-hand corner of the screen.
- When two or more channels of waveforms are displayed, select the channel to measure by pressing **ATTACH**.



Symbol representing a cursor movement

9 500Ps CH1 +DC	<u>158 gV HD: 0%</u>
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Setting the tracking

6 Press TCK/INDEP to select TCK (tracking).

- Function display changes into f:V-TRACK.
- Symbol " I " appears to the left of V cursor 1 and V cursor 2 indicating that both cursors are movable.
- ⑦ Turn [FUNCTION], then V cursor 1 and V cursor 2 move together while maintaining the interval between them.

Release **AV** measurement

Press ΔV to select OFF (no cursor display).

ΔV1/V2=000 IRE display

♦ When the fine adjuster (VARIABLE) is selected on the EIA or CCIR scale, ΔV1/V2=○○○ IRE is displayed.

3 Counter

Measure the frequency of the input signal by the frequency counter.

f = 1.0000 kHz ←

f = 0.0000 Hz



Procedures

① Trigger A (refer to page 29 "Triggering")

- The A trigger frequency is always displayed at the lower right corner of the screen.
- The frequency range is 2 Hz to 500 MHz.
- When A triggering is not set or the input signal exceeds the measuring frequency range, 0 Hz is displayed.

Dual Delay Function

Measures the time difference between two points of the signal with high accuracy and to compare those expanded waveforms.



1 Setting the Dual Delay

1.1 Single Channel

Sets two intensified portions of one channel to display two expanded waveforms.





Procedure

Selection of display channel

① Press CH1, CH2, CH3 or CH4 to select single channel ON (display).

Setting the B sweep rate

- ② Press A and B of the HORIZ DISPLAY mode simultaneously to select ALT.
- ③ Press **AB** to select B.
 - The B indicator lights.
 - Turn [TIME/DIV] to set the B-sweep time.
 - · A sweep and B sweep are displayed.
- Press SOURCE to set the screen with no display of trigger source
 B.

Setting the ∆ t

(5) Press <u>At</u> The delay mark "DLY" is changed to <u>DLY</u> dual delay mode).

Setting the DLY1

- 6 Press TCK/INDEP to select f:B-DLY1 function item.
- ⑦ Turn [FUNCTION] and set the first intensified portion to the measuring point.

Setting the DLY2

- ⑧ Press TCK/INDEP to select f:B-DLY2 function item.
- (9) Turn [FUNCTION] and set the second intensified portion to the measuring point.

Setting of tracking

1 Press TCK/INDEP to select f:B-DLY-TCK function item.

① Turn [FUNCTION], the two intensified portion move together with keeping the span.

Release of dual delay

- Press Δt of CURSOR to select OFF.
- The delay indication is changed to DLY.

1.2 Two or More Channels



ALT

Two delay portions are set at the specified part of a different channel. The channel with the highest priority level is set to DLY1 and the other channels to DLY2.

The priority level is $ADD \rightarrow CH1 \rightarrow CH2 \rightarrow CH3 \rightarrow CH4$.

Procedures (ALT of CH1 and CH2)

Dual delay operation procedure is the same (former page "one channel" 2 to 5, 0 to 1).

Setting the DLY1

- 6 Press TCK/INDEP to select f:B-DLY1 function item.
- ⑦ Turn [FUNCTION] and set the first intensified portion to the measuring point of CH1.

Setting the DLY2

- 8 Press TCK/INDEP to select f:B-DLY2 function item.
- ③ Turn [FUNCTION] and set the second intensified portion to the measuring point of CH2.

· [Example] CH1→DLY1, CH2→DLY2

CHOP

Sets the delay time at the two specified parts of the individual channel on the each displaying waveform. Dual delay operation is the same [former page"one channel" (2) to (5), (0) to (1)].

2 Trace Separation Display in Dual Delay Function

ALT or **B** of the horizontal display mode.

The trace separation display is varvied by in dual delay, the vertical position of DLY1 and DLY2 is controllable to a suitable position by trace separation.

- ALT : Controls [DLY1,DLY2] position from A sweep, can not separates DLY1 and DLY2. (A sweep can not be controled)
- **B** : Controls DLY2 position from DLY1. (DLY1 can not be moved)



Procedures

Setting the ALT

- ① Press A and B of the HORIZONTAL DISPLAY.
- ② Press DELAY/TRACE SEP to select TRACE SEP. The scope displays TR-SEP.
- ③ Turn [FUNCTION] to set the vertical position of the DLY2 (B sweep).
 - When pressing or depressing the [FUNCTION], coarse adjustment is available.



Selecting B

① Press **B** in HORIZ DISPLAY.

② Press DELAY/TRACE SEP to select TRACE SEP. The scope displays TR-SEP.

③ Turn [FUNCTION] to set the vertical position of the DLY2 (B sweep).

• When pressing or depressing the [FUNCTION], coarse adjustment is available.

3 Measuring with Delta Delay Time

Dual delay can measures accurately the delay time difference (Δt) between DLY1 and DLY2.

 $\Delta t = DLY2 - DLY1$ one channel

∆t=CH2-CH1

624¥S

Expanded drawing

DLY2

DLY1

Measuring between two points of the intensified portions.

100ns

DĽY2

two or more channels

f‡15.234



Set DUAL DELAY.

Setting DLY1, DLY2

Refer to page 53 "Setting DLY1, DLY2".

Measuring the delta delay time

[Example : CH2 only]

[Example : CH1 and CH2]

- ① Turn [FUNCTION] to set the DLY1 to the first and DLY2 to the second of the two intensified portions in order to measure the time interval on the A sweep waveform.
- ② Adjust [FUNCTION] precisely to overlap for expanded B-sweep waveform of DLY1 and DLY2.

Readout $\Delta t=\bigcirc\bigcirc\bigcirc \mu$ s displays the measured time difference. [Example] Measuring TV signal

The left waveforms shows measured time difference between the DLY1a point and the DLY2-b point.

Move DLY2-c to DLY2-c' to measure a-c interval.

The delta delay time function can measure accurately between two points by overlapping two B-sweeps.

◇ Delta delay time is effective only by continuous delay (RUNS AFTER) mode.

Since the B sweep in trigger after delay mode starts by the first B trigger signal after the certain delay time, the readout value and delay time on the waveform are not correct (DLY>****ms). (refer to page 43 "Time chart") If you compensate CH2 Delay Adjust (refer to page 39), enable the time difference measuring more accurate.



Save/Recall

Panel setup conditions can be saved and/or recalled.

1 Save

Saves several panel setup conditions.





Procedures

① Set the panel setup conditions.

Setting the register number

2 Press SAVE/RECALL to set to the save mode.

- Function display changes into f:SAVE nn.
- nn : Register number
- ③ Turn [FUNCTION] to select the register number to be saved.
 - The range of register numbers " is 1 to 32.
 - ¹¹ Register numbers
- The max register numbers is set to 32 at the factory shipment. The maximum values is available up to 256 in the system menu. Refer to page 58 "SAVE/RECALL MAX".

Input of a comment

- ④ Press [FUNCTION].
 - The comment-input screen is displayed.
- (5) Input the comment by pressing [FUNCTION] and turning [FUNCTION].
 - Up to 12 characters can be input.
 - Refer to the following page for the details of the method to input the comment.
 - · An example where comment "WAVE1" is input is shown.

Executing save

- 6 Move the cursor to below S of Save by turning [FUNCTION].
- ⑦ Press [FUNCTION].
 - · SAVED is displayed at the lower left corner of the screen.
 - The setup conditions is saved in the displayed number of register and then the save mode is released.
- (8) When saving multiple setup conditions, repeat procedures (1) to (7).

Quitting from the save mode

The SAVE/RECALL key

1: 500.00

The mode is switched as follows by pressing SAVE/RECALL .

‡28

SAVE \rightarrow RECALL \rightarrow OFF (quit from the SAVE/RECALL mode)

However, because the off after entering the RECALL mode, the panel setting is changed to newly recalled setting. • Another function key

When another function key (Example. : the HOLDOFF key) is pressed, it is possible to exit the SAVE mode without any change of the settings.

56

Comment input method

[_ 32 † Changes fr] Save om to : :	f : SAVE		 Procedures ① Cursor moving mode is switched alternately to character selection mode by pressing [FUNCTION]. [-] cursor display (cursor moving mode) The cursor moves to left or right as [FUNCTION] is turned. [::] cursor display (character selection mode) Characters can be selected as [FUNCTION] is turned.
[† Cursor movi] Save	f : SAVE 32	.	② Set the cursor-moving mode by pressing [FUNCTION].
[Character in] Save	f : SAVE 32	~	③ Move the cursor to the character input position by turning [FUNCTION].
[: : † Character se] Save	f : SAVE 32	4	④ Set the character selection mode by pressing [FUNCTION].
[:S: ↑ Select chara] Save	f : SAVE 32	~~	 (5) Select characters by turning [FUNCTION]. Characters can be selected among from numerals, capital letters, and 28 symbols. Space, ! " # \$ % & ' () * +, /:; <=>? @ [¥]^
****	! † Input as th	e 12th character		 6 Input the selected characters by pressing [FUNCTION]. • The cursor moving mode is set.
[<u>S</u> ↑] Save	f : SAVE 32	-	\bigcirc Repeat procedures $\textcircled{3}$ to $\textcircled{6}$.
Cursor movi	ng mode			SKIP If you want to skip some step as step 1, 2, 3, 4, 5 to step 1, 2, 4, 5, if "!" is input at the 12th character of the comment, the register number is skipped in the recall mode. To release the skip function, delete "!" and

skipped in the recall mode. To release the skip function, delete "!" and "!" at 12th character position.

Setting and releasing a skip When a comment has been save the comment. After the function key. The only comment part can

When a comment has been input, that comment is immediately saved, so no more operation is needed to save the comment. After the comment is input, quit the save mode by pressing **SAVE/RECALL** or another function key.

The only comment part can be edited without affecting any setup conditions that are already saved.

2 Recall

Recalls the saved panel setup conditions.



Procedures

1) Press SAVE/RECALL twice to set the recall mode.

Function display changes into f:RECALL nn.
 nn : is the register No. of the current recalling setup conditions.

- ② Select the register no, by turning [FUNCTION].
 - The setup conditions are recalled from the register of the selected no.
 - If "!" is written at the 12th character of the comment, that register number will be skipped. To release the skip, delete the "!" at the 12th character on the comment input screen.

(Refer to page 57 "Comment Input Method").

Quitting the recall mode Press SAVE/RECALL.


Maintenance

a. Daily care

♦ Cleaning

Wipe off the dirt on the cover with damp soft cloth with a small volume of water or mild detergent. If any solvent or cleanser not suitable for cleaning is used, it may cause discoloration or an unexpected fault.

- Solvent or cleanser that can be used : Water and mild detergent
- Solvent or cleanser that cannot be used : Alcohol, gasoline, acetone, lacquer, ether, thinner, and cleansers containing ketone
- ♦ Dirt on the CRT

Remove dirt in the following manner :

- · Wipe off ordinary dirt with a soft cloth.
- · Wipe off stubborn dirt with a cloth dampened with mild detergent.

b. Interval of periodical calibration

To ensure instrument accuracy calibrate once every year or, every 2000 hours in ordinal use. Adjustment interval may be reduced if the instrument is heavy use or harsh environment.

c. Automatic balance adjustment

The following items are adjusted automatically :

- · Trace shift of vertical position when switching the voltage deflection factor.
- GND position.
- · Vertical position.

Cautions Do not push BEAM FIND while automatic balance adjustment. Do not apply any signal is input.

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Procedures

- ① Turn off all the functions to disable [FUNCTION] ¹.
 - ¹ Condition that f:XXXX is not being displayed at the upper right of the screen (the delay time, number of TV lines, etc.)
- ② Turn [READOUT] fully counter clockwise (no readout display).
 - ③ Press [FUNCTION] for 2 sec, then the system menu is displayed.
 - The message as the left picture is displayed at the center of the screen.
- ④ Select AUTO BALANCE ADJUST by turning [FUNCTION].
- ⑤ Press [FUNCTION].
- Sure ? → Yes : Automatic balance adjustment starts.

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I ENHA	E ÖFFS NCED BALAI	INTEN	AD.	JUST	•			
EXIT	DRUM	10 <u>2</u> 7				1		+
sure?		{ 						
10								
1 100 #			A- 7			+ +	0.0	000

The message of adjusting blinks while executing the self adjustment. It will take the approx one minute.

Select EXIT and Press [FUNCTION] to quit the system menu.

◇ If automatic adjusting does not be completed correctly, an error message is displayed. When an error message is displayed after executing automatic adjustment several times, contact to our service stations.

d. Guide to diagnosis

When this instrument does not work or seems to be out of order, check the guide to diagonosis in Table 4.

e. Storage and transportation

♦ Storage

Do not store in the following places:

- Under direct sunlight
- · In dusty enviloment
- In corrosive gas

The conditions for storage of this instrument are as follows :

Storagetemperature : -20 to +70 ℃

Storage humidity : 80 %RH or less (-20 to + 70 °C)

\Diamond Transportation

When transporting this instrument, use original package or more enough cushioned package.

Table 4 Guide to Diagnosis

Symptom	Confirmation items	Remedy
No traces or spots appear.	Check that the power cord plug is connected to the AC receptacle.	Connect the plug to the AC receptacle.
	Check that the power switch is set to ON.	Set the power switch to ON.
	Check that INTEN is turned counter clockwise.	Turn INTEN clockwise until an adequate intensity is obtained.
	Check that SWEEP MODE is set to SINGLE.	Set SWEEP MODE to AUTO.
Characters are not displayed.	Check that READOUT is turned counterclockwise.	Turn READ OUT clockwise until an adequate intensity is obtained.
Focus of traces and characters is not clear.	Check the FOCUS adjustment of FOCUS.	Adjust FOCUS to clear.
Waveform does not appear	Check that the probe is wrong.	Replace the probe.
when signals are input.	Check that the input coupling is set to GND.	Release GND.
	Check whether a wrong channel is selected.	Set the channel to which input signals are connected to ON.
	Check whether the voltage sensitivity is too low.	Increase the sensitivity.
No trigger.		Press AUTO SET.
	Check whether the wrong trigger source is selected.	Select the channel to trigger.
	Check whether the wrong trigger coupling is selected.	Set the trigger coupling mode suitable for input signals.
·	Check whether the level is set to an inadequate position.	Adjust the level to trigger.
Waveform is unstable.	Check whether the AC supply voltage is too low.	Use an AC power supply within the rating.
Former settings are not restored when power is turned on again.		Replace the battery by contacting your nearest lwatsu sales agent.

. •

CH3.CH4

Range

Display

Specifications

Display	
Display type	5.5 inch type, color LCD
Display area	8 div $ imes$ 10 div (1 div=app
CRT storage tube	
Storage type	CCD scan converter tube
Display area	480 $ imes$ 600 pixel (8 div $ imes$ 1
Writing speed	5 div/ns
Persistent time	Variable persistence, Inf
Vertical deflection system (Y a	uxis)
Vertical mode	CH1, CH2, CH3, CH4, A
CH1, CH2	
Deflection factor	
Range	2 mV/div to 5 V/div, 1-2-
Variable control range	2 mV/div to 12.5 V/div co
Frequency characteristics	with internal 50 Ω termin
Bandwidth	DC to 500 MHz -3 dB
	[Note] AC coupled low c
Bandwidth limiter	DC to approx. 20 MHz o
Step response	At 10 mV/div, with interr
Overshoot	6 %
Sag (at 1 kHz)	1 %
Signal delay	At least 20 ns of the swe
Channels skew (CH2 DLY)) 1 ns adjustable CH2 sig
Inputcoupling	AC, DC, GND
Input RC	1 MΩ±1.5 % // 16 pF±
With probe	10 M Ω ±3 % // 12.5 pF:
50 Ω	50 Ω±1 %
Maximum input voltage	
Δ 1ΜΩ	\pm 400 V (DC + ACpeak
50 Ω	5 V rms
VSWR	1.35 MAX (50 Ω : DC to
Offsetvoltage	Vertical deflection
-	

	0.1 V/div to 0.5 V/div
	1 V/div to 5 V/div
Position control range	Approx. \pm 10 div from the
Invert	Available on CH2
ADD	
Accuracy of sum (at 1 kHz)	±3 %
Frequency band width	DC to 500 MHz -3 dB c
Common-mode rejection ratio	at 10 mV/div , CH2 Invert
1 kHz sine wave	80 : 1.6
20 MHz sine wave	80:5.2
Dynamic range	8 div or more 500 MHz inp
-	

) MHz input signal at 10 mV/div full bandwidth 10:1,100:1 detection

100 mV/div, 500 mV/div ±2 %

 $D(240 \times 320 \text{ picture cell}, 30 \text{ dot/div})$ prox. 10 mm, selecting GRID graticule)

e 10 div) finite persistence

ADD (CH1 ±CH2), ALT/CHOP

-5 sequence, 11 steps, Accuracy $\pm 2\%$ ontinuously variable ination or less cutoff frequency (-3 dB) is 10 Hz. or DC to approx. 100 MHz nal 50 Ω termination eep is displayed before the triggering point gnal delay $\pm 2 \, \text{pF}$ $\pm 2 \, \text{pF} (\text{SS-082R})$

Ľ,

k) o 500 MHz)

Vertical deflection range	Offsetvoltage
2 mV/div to 50 mV/div	± 1 V
0.1 V/div to 0.5 V/div	± 10 V
1 V/div to 5 V/div	± 100 V

from the center line of the screen

-3 dB or less

Probe sense **Deflection factor** Accuracy

Bandwidth

Input RC

Maximum input voltage Position control range Dynamic range Probe sense

Triggering

A triggering

Trigger sensitivity

Signal source Coupling Slope B triggering Trigger sensitivity

Signal source Coupling Slope TV scale Voltage setting

Voltage display TV triggering Mode Formats Field and line selection NTSC PAL (SECAM) HDTV TV level

TV clamp

Clamp position Back porch reference Signal amplitude range DC to 500 MHz -3dB or less [Note] AC coupled low cutoff frequency (-3 dB) is 10 Hz 1 M $\Omega \pm 1.5 \%$ // 16 pF ± 3 pF $\pm 400 V$ (DC+ACpeak) Approx. ± 10 div from the center line of the screen 8 div or more 500 MHz input signal full bandwidth 10:1, 100:1 detection

Frequency	Peak to peak signal amplitude
DC to 10 MHz	0.4 div
10 MHz to 100 MHz	1.0 div
10 MHz to 500 MHz	2.0 div

HF-REJ : Attenuates at 10 kHz or more LF-REJ : Attenuates at 10 kHz or less CH1, CH2, CH3, CH4, LINE AC, DC, HF-REJ, LF-REJ +, --

Frequency	Peak to peak signal amplitude
DC to 10 MHz	0.4 div
10 MHz to 100 MHz	1.0 div
10 MHz to 250 MHz	2.0 div

HF-REJ : Attenuates at 10 kHz or more LF-REJ : Attenuates at 10 kHz or less CH1, CH2, CH3, CH4 AC, DC, HF-REJ, LF-REJ +, —

Scale	Automatic setting $(\times 1 \text{ range/full scale})$	Fine adjuster (continuouslyvariable)
EIA	Input voltage 1V=140IRE	65 % to 134 %
CCIR	Input voltage 1V=100IRE	67 % to 132 %
1/CO.1-		

1/50 to ×50 1-2-5 step

TV-V (ODD, EVEN, BOTH) TV-H NTSC, PAL (SECAM), HDTV ODD, EVEN, or BOTH 1 H to 525 H 1 H to 625 H 1 H to 1125 H [Note] TV : The ratio between

[Note] TV : The ratio between the composite video signal and synchronization signal is 7:3 and synchronization signal amplitude is 1.5 div or more.

Back porch level ± 1 div or less from ground reference 1.5 to 8 div

Eventtrigger Count mode Event count range Maximum frequency Burst mode Burst signal interval time **Trigger cursor** Horizontal deflection system (X axis) Horiz display A sweep Sweep mode Sweep rates Maximum sweep Range Variable range Accuracy I 112 Accuracy II *1*2 Hold-off time B sweep Delav B END A Sweep rates Maximum sweep Range Accuracy | *1 Accuracy II " Delay time Position control range Accuracy Delay pickoff jitter Dual delay measuring Sweep magnification Magnifying ratio Accuracy | *1*2 10 ns/div, 50 ns/div 100 ns/div to 500 ms/div Accuracy II *1*2 5 ns/div, 50 ns/div 100 ns/div to 500 ms/div

X-Y operation X axis (CH1) Deflection factor Accuracy Bandwidth Y axis PhasedifferencebetweenXaxisandYaxis 1 to 65535 50 MHz

0.15 μ s to 9.99 s Enable (trigger level is indicated by the cursor)

A, ALT, B, X-Y

AUTO, NORMAL, SINGLE

500 ps/div 5 ns to 500 ms/div 1-2-5 sequence, 25 steps 5 ns to 1.5 s/div ± 2 % over center 8 div ± 5 % over any 2 div within center 8 div Continuously variable

Triggered delay or continuous delay (RUNS AFTER) Enable

500 ps/div 5 ns to 20 ms/div 1-2-5 sequence, 21 steps ± 2 % over center 8 div ± 5 % over any 2 div within center 8 div

0.2 to 10.2 div \pm [(set value×0.005) + (sweep rate×0.1)] -55ns within the range of 1 μ s/div to 500 ms/div 1/20000, at 1 ms/div of A sweep, at 500 ns/div of B sweep Enable

10 times over center 8 div $\pm 5\%$ $\pm 3\%$ over any 2 div within center 8 div $\pm 10\%$ $\pm 5\%$ '' 20 ns or 1 div at the beginning o

¹ 20 ns or 1 div at the beginning of sweep and 20 ns at the end of sweep are excluded.

² Add 1 % in case of VARIABLE ON

Same as CH1. $\pm 2 \%$ DC to 10 MHz, -3 dB or lessCH1, CH2, CH3, CH4, ADD 3° or less (DC to 5 MHz)

AUTO SETUP

Channels Frequency

CAL (Probe calibration signal)

Waveform Frequency Duty ratio Output voltage VIDEO OUT CH2 OUT Output voltage Output dynamic range Output coupling Frequency band width Output resistance

Z AXIS IN

Sensitivity

Frequency range Input resistance Maximum input voltage

FET probe power Measurement with cursors

> Measurement with cursors Type of measurement

Cursor position control range X axis Y axis Y axis Moving pitch step Accuracy specified range X axis Y axis Y axis Accuracy Voltage difference (Δ V) Time difference (Δ V) Time difference (Δ t) MAG OFF MAG ON (MAG x 10) 500 ms to 100 ns/div 50 ns, 5 ns/div

Counter

Number of digits displayed Accuracy Frequency range Input Sensitivity Available CH1 and CH2 50 Hz to 100 MHz

Rectangular wave 1 kHz±0.1 % 49 to 51 % 0.6 V±1 % NTSC composite signal, 1 V±0.3 V into 75 Ω

20 mV/div \pm 30 % (into 50 Ω) \pm 100 mV (50 Ω) DC coupling 200 MHz-3dB (into 50 Ω) 50 Ω \pm 20 %

0.5 Vp-p or more Positive-going input decreases intensity. DC to 5 MHz 5 kΩ ±20 % ±40 V (DC+ACpeak) SFP-5A, SFP-4A, probe power terminals P1, P2

Time difference (Δ t), voltage difference (Δ V) (When the fine adjuster [VARIABLE] is selected on the EIA or CCIR scale, this is displayed in units of IRE)

 ± 5 div from the center line of the screen ± 4 div from the center line of the screen 1/30 div

 \pm 4 div from the center line of the screen \pm 3 div from the center line of the screen

 \pm [(2 % of reading) + (0.3 % of full scale)]

 \pm [(2 % of reading) + (0.3 % of full scale)]

 \pm [(3 % of reading) + (0.3 % of full scale)] \pm [(5 % of reading) + (0.3 % of full scale)] (Full scale : voltage is 8 div, time is 10 div)

5 digits

±0.01 %

2 Hz to 500 MHz

Frequency	Amplitude (div)	
2 Hz to 10 MHz	1.0 div	
10 MHz to 500 MHz	3.0 div	

[Note] The trigger level is set about the center of the waveform on the screen.

Saving data	Backup by built-in battery
Type of data to be saved	 Panel setup conditions just before turning power off¹
	 Saved panel setup conditions (maximum 256)
	 12 characters comment of each panel setup condition
Data retention time	Approx. 27,000H (at approx. 25 °C)
	¹ Under the power cord is disconnected.
Type of battery	Lithium primary battery CR2354-1HF, one piece
Power source	
Voltage range	AC 100 V to 240 V AC
Frequency range	50/60 Hz
Power consumption	140VA MAX
Standby power consumption	Approx. 8VA
Weight and Dimension	
Weight	Approx. 8.5 kg (without accessories)
Dimension	Approx. $320 \times 160 \text{ H} \times 406 \text{ D} \text{ [mm]}$
Environmental conditions	[Note] Without accessories, and projections.
,	10 to 35 °C
Operating	
Temperature	0 to 40 °C
Humidity	90 % RH or less (at 40 ℃)
Storage	50 /8 mm 0 mess (at +0 °C)
Temperature	—20 to 70 ℃
Humidity	80 % RH or less (-20 to 70 °C)
Altitude	
Operating	2,000 m, atmospheric pressure : Approx. 79 kPa
Nonoperating	15,000 m, atmospheric pressure : Approx. 12 kPa
Vibration	15 minutes along each of three axes at a total displacement of 0.67
	mm p.p with frequency varied from 10 Hz to 55 Hz in 1 minute sweep.
Shock	Lifting a side to height of 10 cm and dropping it naturally onto hard
	wood; 4 times on each side.
Droppingpackaged	Dropping an instrument packaged for transportation from a height of 90
	cm.
Warm up time	The specifications for this instrument are assured after more than 30
	min of power on.
CE Declaration of Conformity	The Oscilloscope meets requirements of the Council Directive 89/336/
	EEC for Electromagnetic Compatibility and Low Voltage Directive 73/
	23/ECC for Product Safety.
Electromagnetic Emission	
EN55011:1991	
EN55011:1991	Class B Radiated and Conducted Emissions
EN61000-3-2:1995	AC Power Line Harmonic Current Emissions
EN61000-3-3:1995	Voltage Fluctuations and Flicker
Electromagnetic Susceptibility	
EN50082-2:1995	Electropictic Discharge Immunity
EN61000-4-2:1995 ENV50140:1993	Electrostatic Discharge Immunity
ENV50140.1993 ENV50204:1995	RF Field Strength Susceptibility (Amplitude Moduration) RF Field Strength Susceptibility (Pulse Moduration)
ENV50204.1995	Electrical Fast Transient/Burst Immunity
ENV50141:1993	Conducted Susceptibility
	Conducted Oddooptibility

Low Voltage Directive	
EN61010-1:1993+Amd.2:1995	Safety requirement for electrical equipment for measurement, control,
	and laboratory use.
The oscilloscope has been qualified to the	e following EN61010-1 category:
Installation (Overvoltage) Category II	Pollution Degree 2
Pollution Degree 2	Do not operate in environments where conductive pollutants may be present.
Installation (Overvoltage) Category II	Local Level mains, appliances, portable equipment.

PP005 PROBE

Probe 1

Color rings

Ŧ

INSTRUCTION MANUAL	• • • • • • • • • •	
General Specification (combinated PP005 and LA354)		
The PP005 is a passive probe to use with the LA354 oscilloscope which has frequency	Input RC	$10 M\Omega \pm 3 \% // 11 pF \pm 2 pF^{\Delta}$
response from DC to 500 MHz.	Attenuation ratio	10:1 within ± 2 % [△]
Composition The probe PP005 is composed of a probe body and accessories.	Frequency response	DC to 500 MHz –3 dB [△] • LA354 10mV/div • at the tip of probe
	Input capacitance of applicable oscilloscope	10 to 20 pF
Probe body	13	
Accessories	Maximum safety input	500V (DC + peak AC)
Ground lead 11 cm 1	voltage	
Ground lead short on probe tip 1 IC insulation tip (black) 2	Probe length	Approximately 1.2 m
Spring tip 0.8 mm 1	Connector type	BNC type
Straight tip1	Dood autoomponating	Brouidad
BNC adapter 1	Read-outcompensating function	FIOVIDED
Sprung hook (black)1		
Trimmer tool 1	[▲] For LA354 oscilloscop	e. the probe only described the

The specification of the probe only describes the attached PP005 manual.

Cautions

• Figure 1 shows maximum input voltage. Do not apply excessive voltage.

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MEMO

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